

Activity classification for real-time wearable systems : effect of window length, sampling frequency and number of features on classifier performance

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Advancing novel physical fatigue assessment and human activity monitoring methods towards personalized feedback with wearable sensors = Kantavatel seadmetel põhinevate füüsilise väsimuse hindamise ning inimese aktiivsuse monitoorimise meetodite arendamine personaalseks tagasisideks

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“Al ei mõtle, Al arvutab”. Konverentsil kohtusid tehisaru rakendajad ja entusiastid

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Black-box assessment of optical spectrum services

Kaeval, Kaida; Elbers, Jörg-Peter; Grobe, Klaus; Tikas, Marko; Fehenberger, Tobias; Griesser, Helmut; **Jervan, Gert** 2021 Optical Fiber Communications Conference and Exhibition (OFC) : 6-10 June 2021 : San Francisco, CA, USA 2021 / 3 p
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